Applicant(s)/Patent Under Reexamination Application/Control No. 10/700,946 HAAS ET AL. **Notice of References Cited** Art Unit Examiner Page 1 of 1 Lin Liu 2621 **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0027467	02-2004	Shiga, Hideaki	348/231.99
*	В	US-2004/0075750	04-2004	Bateman, John	348/231.1
*	С	US-2004/0061788	04-2004	Bateman, John	348/220.1
*	D	US-2006/0268117	11-2006	Loui et al.	348/220.1
	Ε	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			·
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					•
	R					·
	s	•				
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	>	
	8	
	×	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.